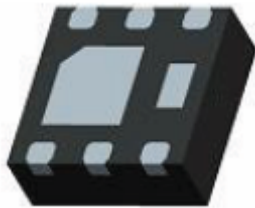


General Description

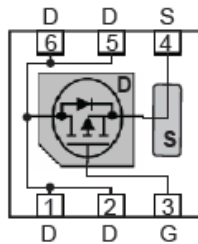
These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

Features

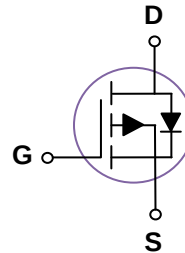
V_{DS}	-12V
I_D (at $V_{GS}=-4.5V$)	-16A
$R_{DS(ON)}$ (at $V_{GS}=-4.5V$)	12m Ω (Typ)



DFN2020-6L



Pin configuration (Top view)



Absolute Maximum Ratings $T_A=25^{\circ}C$ unless otherwise noted

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V_{DS}	-12	V
Gate-Source Voltage		V_{GS}	± 10	V
Drain Current-Continuous	TC=25 $^{\circ}C$	I_D	-16	A
	TC=100 $^{\circ}C$	I_D	-10	A
Maximum Power Dissipation		P_D	18	W
Drain Current – Pulsed1		I_{DM}	-65	A
Junction and Storage Temperature Range		T_J, T_{STG}	-55 To 150	$^{\circ}C$

Thermal Characteristics

Parameter	Symbol	Typ	Max	Unit
Thermal Resistance junction-case	$R_{\theta Jc}$		38	$^{\circ}C / W$
Thermal Resistance junction-to-Ambient	$R_{\theta JA}$		80	$^{\circ}C / W$

Electrical Characteristics (TJ=25°C unless otherwise noted)

Symbol	Parameter	Condition	Min	Typ	Max	Unit
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V I _D =-250μA	-12			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-12V,V _{GS} =0V			1	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} =±12V,V _{DS} =0V			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} ,I _D =-250μA	-0.4	-0.7	-1.0	V
R _{DS(ON)}	Drain-Source On-State Resistance	V _{GS} =-4.5V, I _D =-6.7A		12	15	mΩ
		V _{GS} =-2.5V, I _D =-6.2A		16	23	mΩ
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance	V _{DS} =-10V,V _{GS} =0 V, F=1.0MHz		2700		pF
C _{OSS}	Output Capacitance			680		pF
C _{rSS}	Reverse Transfer Capacitance			590		pF
SWITCHING PARAMETERS						
t _{d(on)}	Turn-on Delay Time	V _{DD} =-6V,I _D =-1A , V _{GS} =-4.5V, R _G =10Ω		11		nS
t _r	Turn-on Rise Time			35		nS
t _{d(off)}	Turn-Off Delay Time			30		nS
t _f	Turn-Off Fall Time			10		nS
Q _g	Total Gate Charge	V _{DS} =-6V,I _D =-10 A, V _{GS} =-4.5V		35		nC
Q _{gs}	Gate-Source Charge			5		nC
Q _{gd}	Gate-Drain Charge			10		nC
V _{SD}	Diode Forward Voltage	V _{GS} =0V,I _{SD} =-1A		0.72	1.4	V
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz		4		Ω

Note:

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
3. Essentially independent of operating temperature.

Typical Performance Characteristics

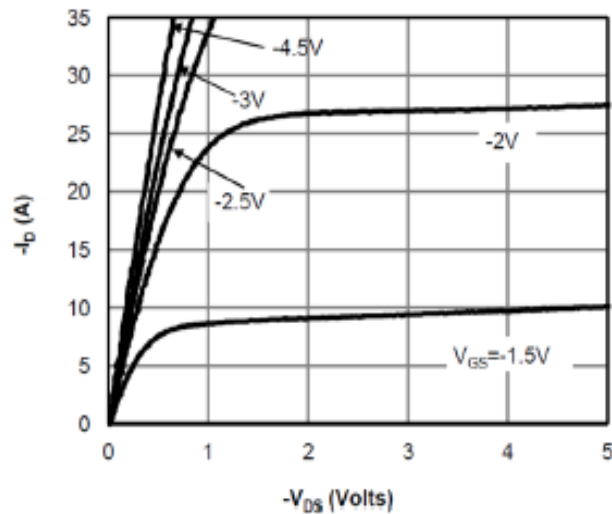


Fig 1: On-Region Characteristics

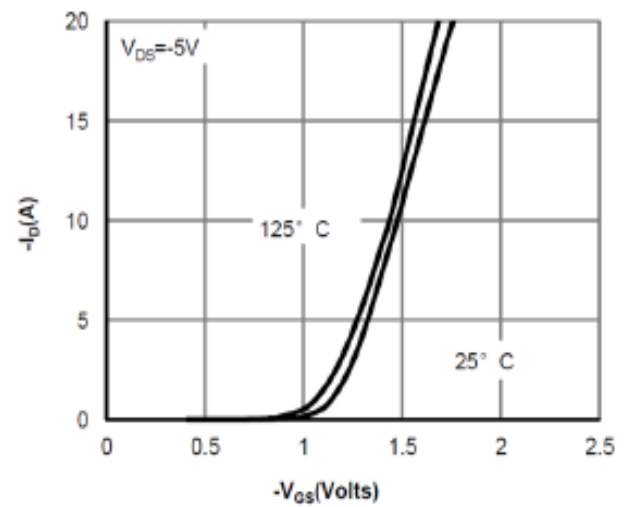


Figure 2: Transfer Characteristics

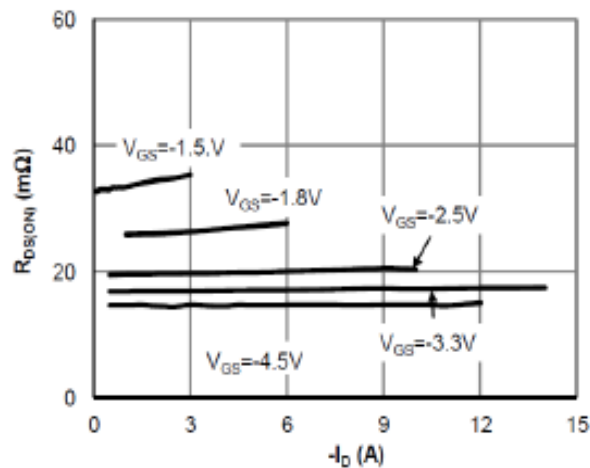


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

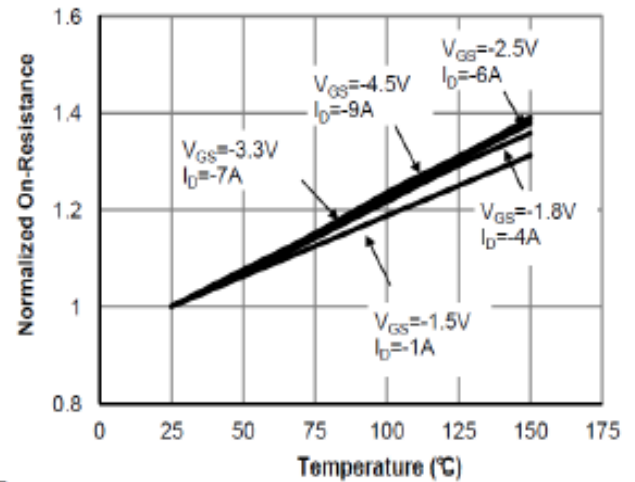


Figure 4: On-Resistance vs. Junction Temperature

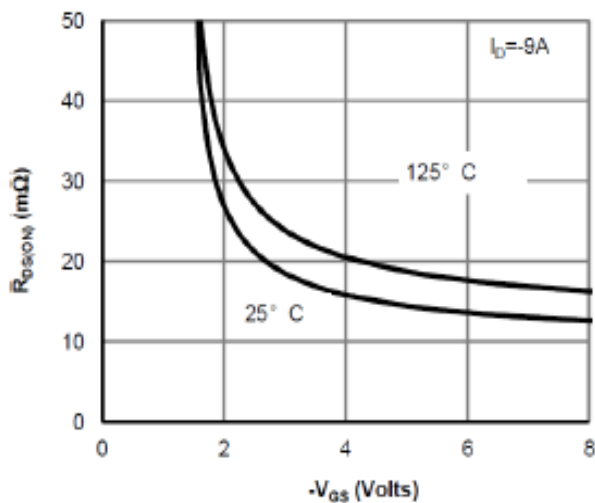


Figure 5: On-Resistance vs. Gate-Source Voltage

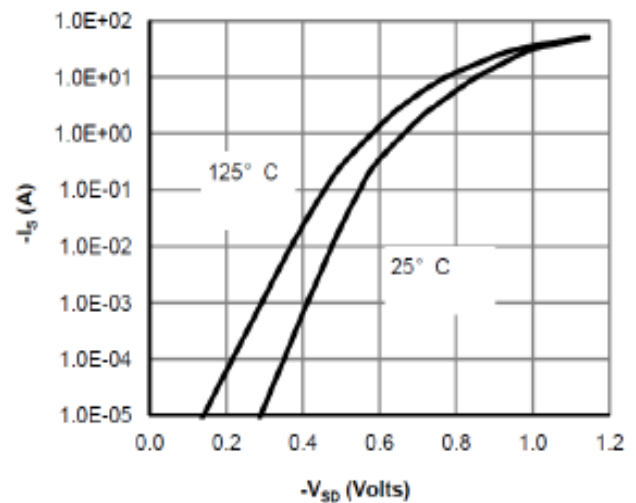
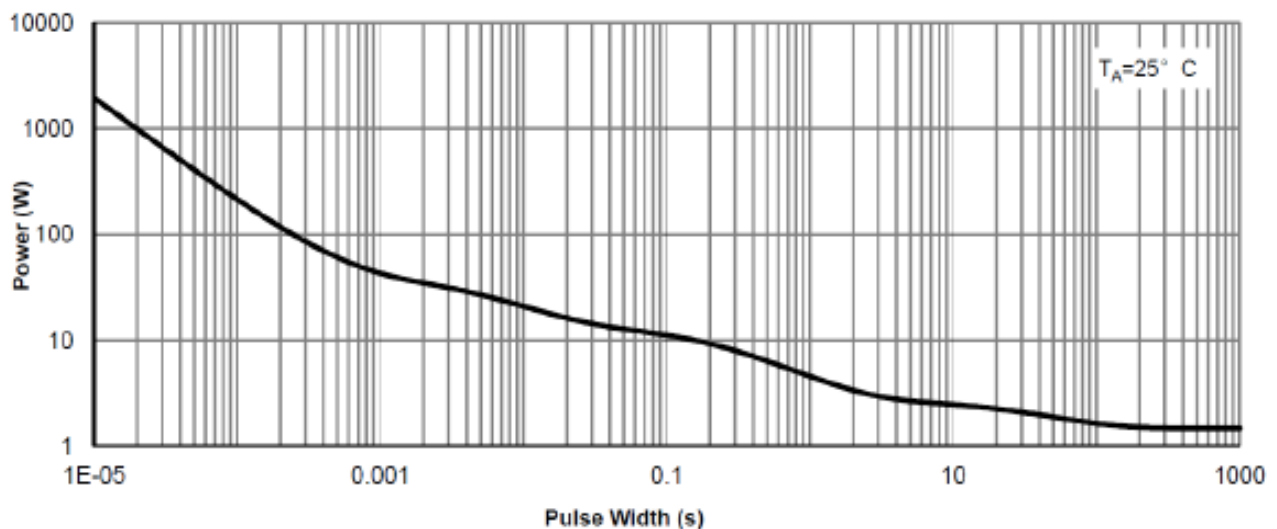
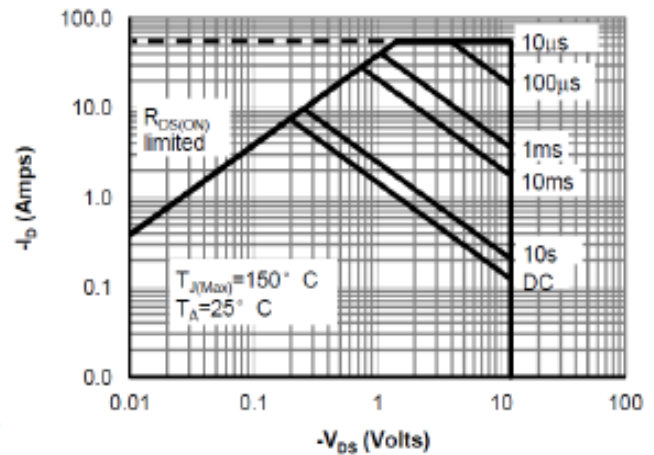
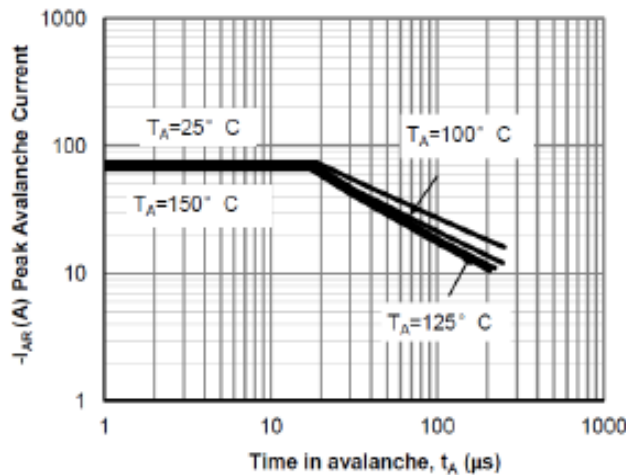
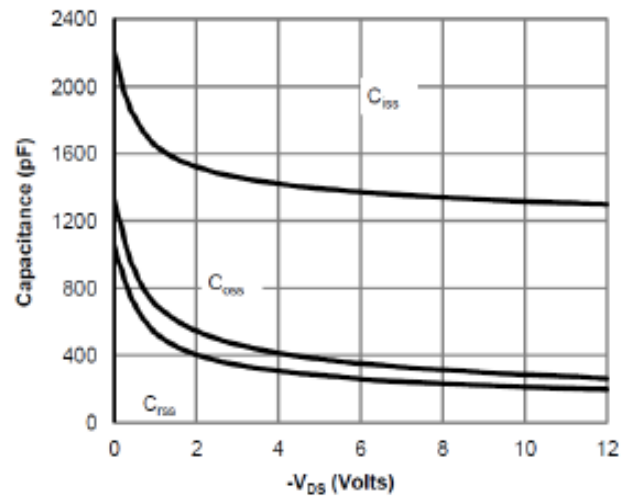
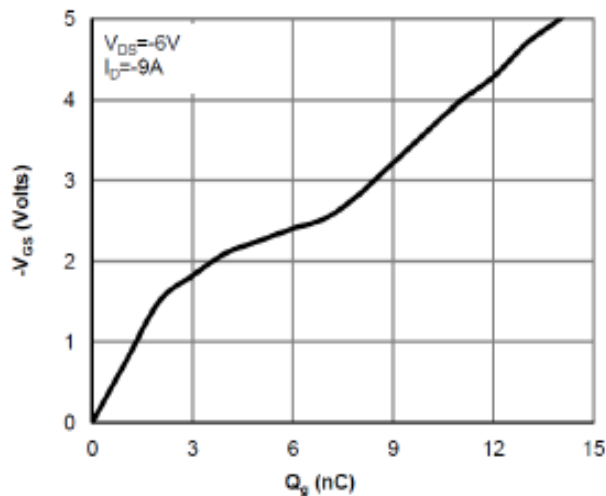
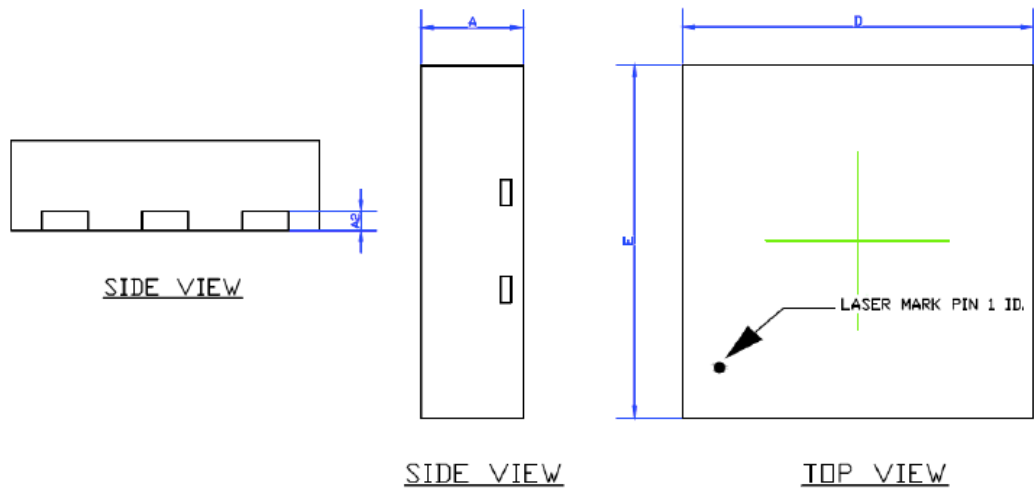


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



DFN2020-6L PACKAGE INFORMATION



COMMON DIMENSION (MM)			
PKG	DFN2020-6L-4		
SYMBOL	MIN.	NOM.	MAX
A	0.527	0.552	0.577
A2		0.127REF	
b	0.25	0.30	0.35
D	1.90	2.00	2.10
E	1.90	2.00	2.10
D1	0.85	0.95	1.05
E1	1.05	1.15	1.25
D2	0.20	0.25	0.30
E2	0.69	0.79	0.89
e	0.55	0.65	0.75
H	0.25	0.30	0.35
K1	0.25MIN		
K2	0.15MIN		
K3	0.20MIN		
L	0.20	0.25	0.30

